50	Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/032,097	LEE ET AL.	
Examiner	Art Unit	
Neeraj Bhatia	2661	

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Class	Subclass	Date	Examiner	
370	395,378, 379,412	9/16/2005	NB	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
370/395,378,379,412 (text search only- see search history printout)	9/16/2005	NB
EAST: US-PG PUB;USPAT;USOCR (lext search only - see search history printout)	9/16/2005	NB
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